


<b>Search Notes</b> 	<b>Application/Control No.</b> 10517219	<b>Applicant(s)/Patent Under Reexamination</b> CHRISTEN, YVES
	<b>Examiner</b> Chen, Catheryne	<b>Art Unit</b> 1655

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
none	none	3/14/07	cc

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
invetor name, USPT, PGPB, JPAB, EPAB, DWPI, Medline, Embase, Bisosis, Caplus, Registryn	3/14/07	cc

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>